Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	•
10/658,840	DAMMEL ET AL.	
Examiner	Art Unit	
John S. Chu	1752	

	SEARCHED				
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST SEARCH UPDATED	-4/201b	gu	
INVENTOR SEARCH UPDATED			
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